

<b>Notice of References Cited</b>	Application/Control No. 10/076,063	Applicant(s)/Patent Under Reexamination KONZ ET AL.	
	Examiner Van Kim T. Nguyen	Art Unit 2151	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,452,938	09-2002	Fawal et al.	370/463
	B	US-5,316,311	05-1994	Lee, Miryoung	273/348.4
	C	US-5,801,602	09-1998	Fawal et al.	333/177
	D	US-5,671,249	09-1997	Andersson et al.	375/211
	E	US-5,646,368	07-1997	Muyschondt et al.	174/33
	F	US-5,640,585	06-1997	Smoot et al.	712/38
	G	US-5,590,369	12-1996	Burgess et al.	710/110
	H	US-5,511,152	04-1996	Lai et al.	358/1.16
	I	US-5,223,806	06-1993	Curtis et al.	333/12
	J	US-4,379,327	04-1983	Tietjen et al.	710/61
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.